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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/778,744	02/08/2001	Ramesh H. Kakkad	108530	6894
25944	7590	09/24/2002	EXAMINER	
OLIFF & BERRIDGE, PLC P.O. BOX 19928 ALEXANDRIA, VA 22320			COLEMAN, WILLIAM D	
		ART UNIT	PAPER NUMBER	
		2823		
DATE MAILED: 09/24/2002				

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary	Application No.	Applicant(s)
	09/778,744	KAKKAD, RAMESH H.
	Examiner W. David Coleman	Art Unit 2823

-- The MAILING DATE of this communication app ars on the cover sheet with the correspondence address --
Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) Responsive to communication(s) filed on 08 February 2001.
- 2a) This action is FINAL. 2b) This action is non-final.
- 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) Claim(s) 1-21 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) Claim(s) _____ is/are allowed.
- 6) Claim(s) 1-21 is/are rejected.
- 7) Claim(s) _____ is/are objected to.
- 8) Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) The specification is objected to by the Examiner.
- 10) The drawing(s) filed on _____ is/are: a) accepted or b) objected to by the Examiner.
 Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- 11) The proposed drawing correction filed on _____ is: a) approved b) disapproved by the Examiner.
 If approved, corrected drawings are required in reply to this Office action.
- 12) The oath or declaration is objected to by the Examiner.

Priority under 35 U.S.C. §§ 119 and 120

- 13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) All b) Some * c) None of:
1. Certified copies of the priority documents have been received.
2. Certified copies of the priority documents have been received in Application No. _____.
3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.
- 14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).
- a) The translation of the foreign language provisional application has been received.
- 15) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.

Attachment(s)

- | | |
|--|---|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413) Paper No(s). _____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO-1449) Paper No(s) _____ | 6) <input type="checkbox"/> Other: _____ |

DETAILED ACTION

Specification

1. The title of the invention is not descriptive. A new title is required that is clearly indicative of the invention to which the claims are directed.

Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(e) the invention was described in–
(1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effect under this subsection of a national application published under section 122(b) only if the international application designating the United States was published under Article 21(2)(a) of such treaty in the English language; or
(2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that a patent shall not be deemed filed in the United States for the purposes of this subsection based on the filing of an international application filed under the treaty defined in section 351(a).

3. Claims 1-21 are rejected under 35 U.S.C. 102(e) as being anticipated by Arkles et al., U.S. Patent Publication No. US 2002/0119327 A1.

4. Arkles discloses a semiconductor process as claimed.

Pertaining to claim 1, Arkles teaches a method for fabricating a film, the method comprising:

supplying electrical energy [paragraph 0038] to a gas mixture of noble gas [0026] and reactant gas at a total pressure of 90 kPa to 110 kPa [0050] to create reactive species, the reactive species [0026] forming a film on a substrate [Abstract].

5. Pertaining to claim 2, Arkles teaches the method of claim 1, said energy being supplied to the gas mixture by electric power in a frequency range of 1 kHz to 100 MHz [0038].

6. Pertaining to claim 3, Arkles teaches the method of claim 1, one of helium, argon, neon krypton, xenon or one of a mixture of at least two chosen from a group consisting of helium, argon neon, krypton and xenon being used as noble gas [0026].
7. Pertaining to claim 4, Arkles teaches the method of claim 1, temperature of the substrate on which said film is to be formed being in a range of 25 to 500⁰C [0018].
8. Pertaining to claim 5, Arkles teaches the method of claim 1, the film being silicon, oxide or having a composition close to silicon dioxide [0018].
9. Pertaining to claim 6 Arkles teaches the method of claim 1, the film being silicon nitride or having a composition close to silicon nitride [0018].
10. Pertaining to claim 7, Arkles teaches the method of claim 1, the film being one of a silicon film, a doped silicon film, and a hydrogenated-silicon film [0011].
11. Pertaining to claim 8, Arkles teaches the method of claim 1, the film being one of a metal and an alloy film [0013 (silicon alloys with aluminum which is a metal)].
12. Pertaining to claim 9, Arkles teaches a semiconductor device comprising a film fabricated according to the method of claim 1 [0001].
13. Pertaining to claim 10, Arkles teaches the semiconductor device of claim 9, the semiconductor device being one of a metal oxide semiconductor field effect transistor device, a thin film transistor, and a silicon on insulator device [0001].
14. Pertaining to claim 11, Arkles teaches the semiconductor device of claim 9, the semiconductor device being a photovoltaic device (i.e., solar applications) [0001].
15. Pertaining to claim 12, Arkles teaches an electro-optical apparatus comprising the semiconductor device of claim 9 [0058 (i.e., flat panel display)].

16. Pertaining to claim 13, Arkles teaches a memory device comprising a film fabricated according to the method of claim 1 [0001].

17. Pertaining to claim 14, Arkles teaches the memory device of claim 13, the memory device being one of a metal oxide semiconductor field effect transistor device, a thin film transistor, and a silicon on insulator device [0001].

18. Pertaining to claim 15, Arkles teaches the memory device of claim 13, the memory device being a photovoltaic device [0001].

19. Pertaining to claim 16, Arkles teaches a method for fabricating a film, the method comprising:

supplying electrical energy to a gas mixture of noble gas and reactant gas at a total pressure of 1 kPa to 110 kPa to create reactive species, the reactive species forming a film on a substrate.

20. Pertaining to claim 17, Arkles teaches a method for fabricating a film, the method comprising:

supplying optical energy with a light of wavelength less than 200 nanometer to a mixture of noble gas and reactant gas to create reactive species, the reactive species forming a film on a substrate [0044].

21. Pertaining to claim 18, Arkles teaches a semiconductor device comprising a film fabricated according to the method of claim 17.

22. Pertaining to claim 19, Arkles teaches a memory device comprising a film fabricated according to the method of claim 17.

23. Pertaining to claim 20, Arkles teaches a method for fabricating a semiconductor device, the method comprising:

a step of forming a film by supplying electrical energy to a mixture of noble gas and reactant gas at a total pressure of 90 kPa to 110 kPa to create reactive species, the reactive species forming a film on a substrate.

24. Pertaining to claim 21, Arkles teaches a method for fabricating a memory device, the method comprising:

a step of forming a film by supplying electrical energy to a mixture of noble gas and reactant gas at a total pressure of 90 kPa to 110 kPa to create reactive species, the reactive species forming a film on a substrate.

Conclusion

25. Any inquiry concerning this communication or earlier communications from the examiner should be directed to W. David Coleman whose telephone number is 703-305-0004. The examiner can normally be reached on 9:00 AM-5:00 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Wael M. Fahmy can be reached on 703-308-4918. The fax phone numbers for the organization where this application or proceeding is assigned are 703-308-7722 for regular communications and 703-308-7721 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-308-0956.



W. David Coleman
Examiner
Art Unit 2823

WDC
September 21, 2002